

Notice of References Cited	Application/Control No. 10/776,753	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Parham (Paul) R. Fatehi	Art Unit 2194	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,108,533 A	08-2000	Brohoff, H.ang.kan Torgny	455/414.3
*	B	US-2002/0038386 A1	03-2002	Bhatia et al.	709/250
*	C	US-2002/0038362 A1	03-2002	Bhatia et al.	709/224
*	D	US-2002/0147790 A1	10-2002	Snow, Andrew J.	709/217
*	E	US-2002/0169847 A1	11-2002	Luna et al.	709/216
*	F	US-6,741,188 B1	05-2004	Miller et al.	340/995.1
*	G	US-6,760,046 B2	07-2004	I'Anson et al.	715/746
*	H	US-6,839,743 B2	01-2005	Shim, Jae-Bum	709/217
*	I	US-6,928,230 B2	08-2005	Squibbs, Robert Francis	386/46
*	J	US-6,970,869 B1	11-2005	Slaughter et al.	707/10
*	K	US-7,072,967 B1	07-2006	Saulpaugh et al.	709/229
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.